Notice of References Cited Application/Control No. 10/817,567 Examiner D. Rutledge Applicant(s)/Patent Under Reexamination LIN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,893,004	04-1999	Yamamura, Takenori	396/611
*	В	US-6,203,218	03-2001	Omori et al.	396/611
*	С	US-6,759,179	07-2004	Phan et al.	430/311
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-		·	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N _.				·	
	0					
	ъ		,			
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.